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Dual P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^d	Q _g (Typ.)		
- 60	0.068 at V _{GS} = - 10 V	-5.5	26 nC		
- 00	0.080 at V _{GS} = - 4.5 V	-5	20110		

SO-8

Top View

G₁

 S_2

 G_2

 D_1

 D_1

 D_2

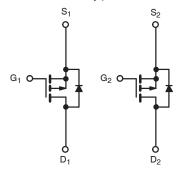
 D_2

FEATURES

- DT-Trench Power MOSFET
- $\bullet\,$ 100 % R_g and UIS Tested

APPLICATIONS

- Power management
- Load switch
- Battery protection





	P-Channel M	MOSFET P-Channel M	OSFET		
ABSOLUTE MAXIMUM RATINGS (7	$\Gamma_A = 25 ^{\circ}\text{C}$, unless oth	nerwise noted)			
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 60	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		-5.5		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C] _ [-4.5		
Continuous Diain Curient (1) = 130 C)	T _A = 25 °C	I _D	-2 ^{a,b}		
	T _A = 70 °C	1	-0.8 ^{a,b}		
Pulsed Drain Current	I _{DM}	-22 ^e	Α		
0 11 0 0 0 1	T _C = 25 °C	1.	- 5.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.0 ^{a, b}		
Avalanche Current	L = 0.1 mH	I _{AS}	-20 ^e		
Single-Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	24	mJ	
	T _C = 25 °C		8		
Mayimum Dayer Dissination	T _C = 70 °C] , [6.6	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.0 ^{a, b}	VV	
	T _A = 70 °C		1.9 ^{a, b}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	25	38	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	59	85	- C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 $^{\circ}\text{C/W}.$
- d. Based on T_C = 25 °C.e. Limited by package.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	ΔVps/Tι		- 52		\//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = - 250 μA		4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 O-t V-lt Dunin Oursent	1	V _{DS} = - 48 V, V _{GS} = 0 V			- 1	- 1 - 10 μA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 48 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-20			Α	
	_	V _{GS} = - 10 V, I _D = - 5 A		0.068	0.075	1 _	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 4.5 A	0.080 0.09		0.090	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 5 A		15		S	
Dynamic ^b		-			,		
Input Capacitance	C _{iss}			1395			
Output Capacitance	C _{oss}	V _{DS} = - 48 V,V _{GS} = 0 V , f = 1 MHZ		305		pF	
Reverse Transfer Capacitance	C _{rss}			48			
Total Gate Charge	Qg	V _{DS} = -48 V, V _{GS} = -10 V, I _D = -5 A		26	45		
				20			
Gate-Source Charge	Q _{gs}	V _{DS} = - 48, V _{GS} = - 4.5 V, I _D = - 4.5 A		4.6		nC	
Gate-Drain Charge	Q _{gd}			6.8			
Gate Resistance	R _g	f = 1 MHz		8		Ω	
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	$V_{DD} = -48 \text{ V}, R_{L} = 2 \Omega$		9	18		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -2 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		60	100	1	
Fall Time	t _f			25	46		
Turn-On Delay Time	t _{d(on)}			15	30	ns	
Rise Time	t _r	$V_{DD} = -48V, R_{L} = 2 \Omega$		14	28		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		74	110		
Fall Time	t _f			38	75	-	
Drain-Source Body Diode Characterist							
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 5.5		
Pulse Diode Forward Current	I _{SM}				- 22	Α	
Body Diode Voltage	V _{SD}	I _S = -2 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	0 00		27	50	ns	
Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a				22	65	nC	
		$I_F = -2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10	- 55	ns	
Reverse Recovery Rise Time		t _b		15			

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

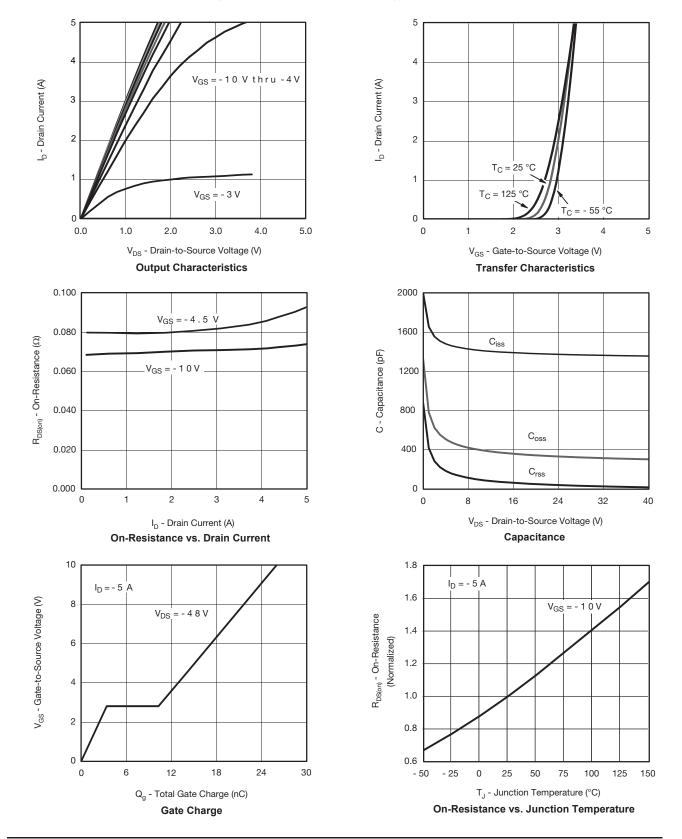
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.



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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

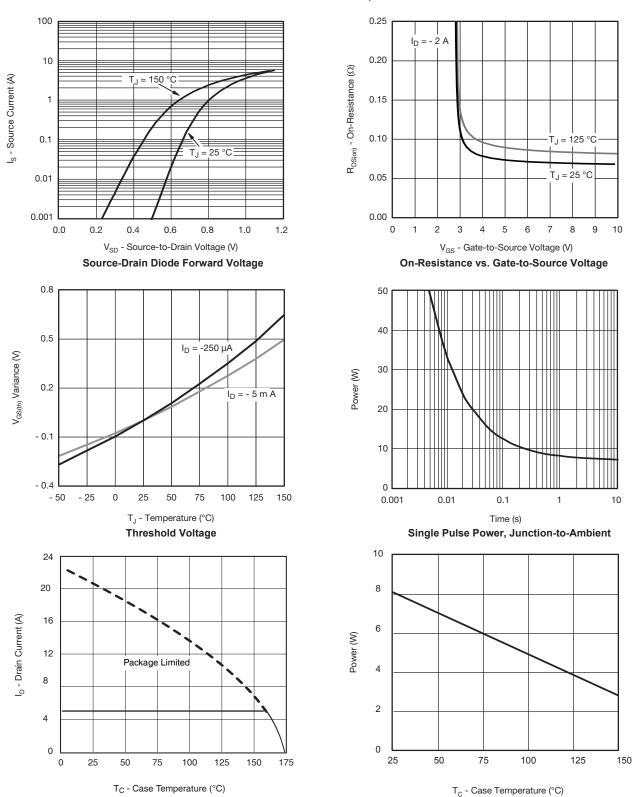


Power, Junction-to-Foot



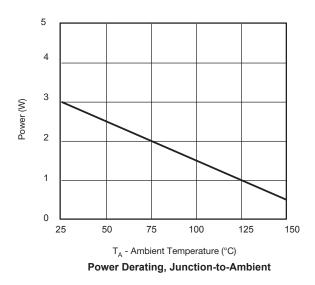
TYPICAL CHARACTERISTICS (25 °C. unless otherwise noted)

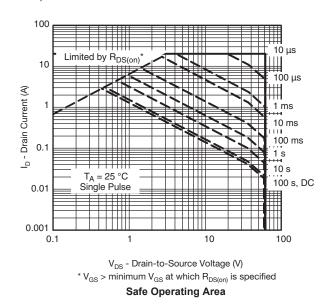
Current Derating*



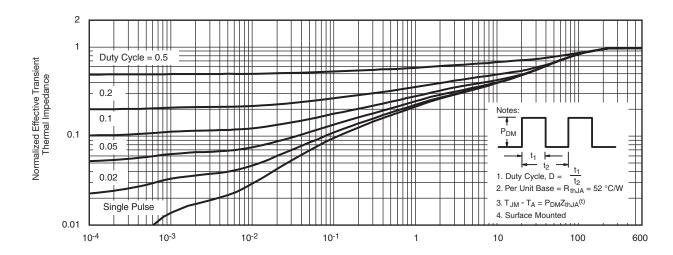


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Square Wave Pulse Duration (s)

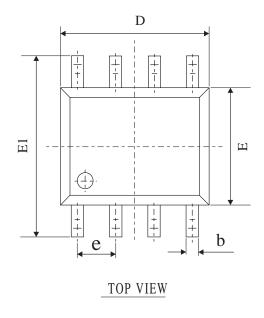
Normalized Thermal Transient Impedance, Junction-to-Ambient

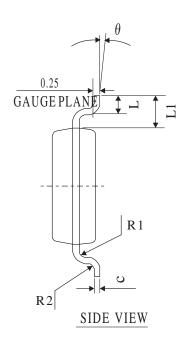


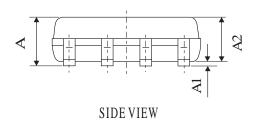
Din-Tek SEMICONDUCTOR

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SOP-8 PACKAGE OUTLINE







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	
A	1.30	1.60	1.85	
A1	0.03	0.15	0.28	
A2	1.20	1.45	1.70	
b	0.26	0.40	0.54	
С	0.132	0.203	0.273	
D	4.50	4.90	5.30	
Е	3.50	3.00	4.30	
E1	5.50	6.00	6.50	
L	0.30	0.70	1.10	
θ	2°	4°	6°	
L1	1.04REF			
e	1.27BSC			
R1	0.07TYP			
R2	0.07TYP			



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